ADC_Background_Scan_1 for KIT_AURIX_TC297_TFT

ADC background scan source

AURIX[™] TC2xx Microcontroller Training V1.0.1



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The Versatile Analog-to-Digital Converter (VADC) is configured to measure multiple analog signals in a sequence using background scan request.

The Background Scan mode of the Analog-to-Digital Converter (ADC) module is configured to measure the analog signals applied to the channels 0 to 3 of the group 0.



Introduction

- The Versatile Analog-to-Digital Converter module (VADC) of the AURIX[™] TC29x comprises 11 independent analog to digital converters (VADC groups) with up to 8 analog input channels each.
- > Each channel can convert analog inputs with a resolution of up to 12-bit.
- > Analog/Digital conversions can be requested by several request sources:
 - **Queued request source**, specific to a single group
 - Channel scan request source, which comprises:
 - **Group scan source**, specific to a single group
 - **Background scan source**, which can request all channels of all groups
- > The Channel scan request source issues conversion requests for a coherent sequence of input channels, starting with the highest enabled channel number.
- In background scan source (Channel scan request source), each channel is converted once per sequence. A conversion can be requested to be done once or repeatedly.
- > A background scan source can access all analog input channels that are not assigned to any group request source. These conversions are executed with low priority.



Hardware setup



This code example has been developed for the board KIT_AURIX_TC297_TFT_BC-Step. The signals to be measured have to be connected to channels 0..3 of the VADC (port pins AN0..AN3).

X102				
P14.5	40	39	P14.4	
P20.10	38	37	P20.9	
P15.7	36	35	P15.6	
P15.5	34	33	P15.4	
P15.3	32	31	P15.2	
P22.3	30	29	P22.2	
P22.1	28	27	P22.0	
P33.11	26	25	P23.4	
P23.3	24	23	P23.2	
P23.1	22	21	P23.0	
P33.6	20	19	P33.8	
P33.12	18	17	P33.1	
P33.2	16	15	P33.3	
P33.4	14	13	P33.5	
ANO	12	11	AN8	
AN2	10	9	AN3	
AN32	8	7	AN33	
AN20	6	5	AN21	
GND	4	3	GND	
V_UC(+5V)	2	1	VCC_IN	

Note: The port pin AN1 is not routed to any accessible pin on the KIT_AURIX_TC297_TFT_BC-Step board, thus this pin will read a random analog noise value.



Implementation

Configuration of the VADC

The configuration of the VADC is done in the *initADC()* function in three different steps:

- > Configuration of the VADC module
- > Configuration of the VADC group
- > Configuration of the VADC channel

Configuration of the VADC module

The default configuration of the VADC module, given by the iLLDs, can be used for this example. This is done by initializing an instance of the *IfxVadc_Adc_Config* structure and applying default values to its fields through the function *IfxVadc_Adc_initModuleConfig()*.

Then, the configuration can be applied to the VADC module with the function *lfxVadc_Adc_initModule()*.



Implementation

Configuration of the VADC group

The configuration of the VADC group is done by initializing an instance of the *lfxVadc_Adc_GroupConfig* structure with default values through the function *lfxVadc_Adc_initGroupConfig()* and modifying the following fields:

- > groupId to select which converters to configure
- master to indicate which converter is the master. In this example, only one converter is used, therefore it is also the master
- arbiter a structure that represents the enabled request sources, which can be Group scan, Queue and/or Background sources. In this example, it is set to arbiter.requestSlotBackgroundScanEnabled.
- backgroundScanRequest a structure that allows to configure the Background Scan Request Source by setting:
 - autoBackgroundScanEnabled a parameter to set the autoscan mode (conversions are requested continuously)
 - triggerConfig a parameter that specify the trigger configuration

Then, the user configuration is applied through the function *lfxVadc_Adc_initGroup()*.



Implementation

Configuration of the VADC channel

The configuration of each channel is done by initializing an instance of the *lfxVadc_Adc_ChannelConfig* structure with default values through the function *lfxVadc_Adc_initChannelConfig()* and modifying the following fields:

- **channelld** to select the channel to configure
- > **resultRegister** to indicate the register where the A/D conversion value is stored
- **backgroundChannel** to specify that the selected channel is used as a background channel

Then, the configuration is applied to the channel with the function *lfxVadc_Adc_initChannel()* and, as a last step, the channel is added to the background scan sequence through the function *lfxVadc_Adc_setBackgroundScan()*.

When the VADC module and its groups and channels are configured, the scan sequence is started with the function *lfxVadc_Adc_startBackgroundScan()*.

Finally, to read a conversion, the function *readADCValue()* is used, which calls the *lfxVadc_Adc_getResult()* function from iLLDs until a new measurement is returned.

All the functions used to get a conversion and configuring the VADC module, its group and channels can be found in the iLLD header *IfxVadc_Adc.h*.



Run and Test

After code compilation and flashing the device, perform the following steps:

- Set a breakpoint in the Cpu0_Main.c file where the first measurement is requested (chn0Measurement = readADCValue(CHN_0))
- Resume twice the Debug session and check the Variables window where the conversion values can be seen

(x)= Variables 🖾 💁 Breakpoints 🙀	Expressions	1 📩 🎿 🕞 📬 🧯 🗱 💥 🗢 🗖
Name	Туре	Value
(×)= chn0Measurement	unsigned short	1538
(×)= chn1Measurement	unsigned short	2774
(x)= chn2Measurement	unsigned short	1817
(x)= chn3Measurement	unsigned short	4095

References











- AURIX[™] Development Studio is available online: >
- https://www.infineon.com/aurixdevelopmentstudio
- Use the *"Import…"* function to get access to more code examples. >
- More code examples can be found on the GIT repository: >
- https://github.com/Infineon/AURIX code examples >
- For additional trainings, visit our webpage: >
- https://www.infineon.com/aurix-expert-training >
- For questions and support, use the AURIX[™] Forum: >
- https://www.infineonforums.com/forums/13-Aurix-Forum >



Revision history

Revision	Description of change
V1.0.1	Update of version to be in line with the code example's version
V1.0.0	Initial version

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Edition 2020-12 Published by Infineon Technologies AG 81726 Munich, Germany

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Document reference ADC_Background_Scan_1_ KIT_TC297_TFT

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